

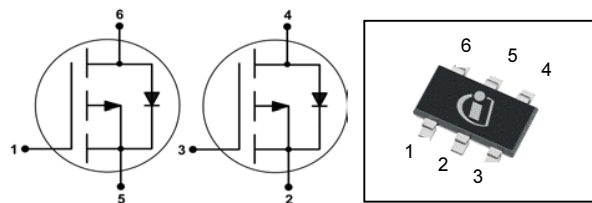
**OptiMOS™ P2 Small-Signal-Transistor**
**Features**

- Dual P-channel
- Enhancement mode
- Super Logic Level (2.5V rated)
- Avalanche rated
- Qualified according to AEC Q101
- 100% lead-free; RoHS compliant


**Product Summary**

$V_{DS}$	-20	V
$R_{DS(on),max}$	$V_{GS}=-4.5\text{ V}$	150
	$V_{GS}=-2.5\text{ V}$	280
$I_D$	-1.5	A

PG-TSOP6



Type	Package	Tape and Reel Information	Marking	Lead Free	Packing
BSL215P	PG-TSOP6	L6327: 3000 pcs/ reel	sPG	Yes	Non dry

**Maximum ratings, at  $T_j=25\text{ °C}$ , unless otherwise specified**

Parameter <sup>1)</sup>	Symbol	Conditions	Value	Unit
Continuous drain current	$I_D$	$T_A=25\text{ °C}$	-1.5	A
		$T_A=70\text{ °C}$	-1.18	
Pulsed drain current	$I_{D,pulse}$	$T_A=25\text{ °C}$	-6	
Avalanche energy, single pulse	$E_{AS}$	$I_D=-1.5\text{ A}$ , $R_{GS}=25\text{ }\Omega$	11	mJ
Reverse diode $dv/dt$	$dv/dt$	$I_D=-1.5\text{ A}$ , $V_{DS}=-16\text{ V}$ , $di/dt=-200\text{ A}/\mu\text{s}$ , $T_{j,max}=150\text{ °C}$	6	kV/ $\mu\text{s}$
Gate source voltage	$V_{GS}$		$\pm 12$	V
Power dissipation	$P_{tot}$	$T_A=25\text{ °C}$	0.5	W
Operating and storage temperature	$T_j$ , $T_{stg}$		-55 ... 150	$^{\circ}\text{C}$
ESD Class		JESD22-A114 -HBM	0 (<250V)	V
Soldering Temperature			260 $^{\circ}\text{C}$	$^{\circ}\text{C}$
IEC climatic category; DIN IEC 68-1			55/150/56	$^{\circ}\text{C}$

<sup>1)</sup> Remark: one of both transistors in operation.

Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	

**Thermal characteristics**

Thermal resistance, junction - ambient	$R_{thJA}$	minimal footprint <sup>2)</sup>	-	-	250	K/W
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**Electrical characteristics, at  $T_j=25\text{ °C}$ , unless otherwise specified**
**Static characteristics**

Drain-source breakdown voltage	$V_{(BR)DSS}$	$V_{GS}=0\text{ V}, I_D=-250\text{ }\mu\text{A}$	-20	-	-	V
Gate threshold voltage	$V_{GS(th)}$	$V_{DS}=V_{GS}, I_D=-11\text{ }\mu\text{A}$	-1.2	-0.9	-0.6	
Drain-source leakage current	$I_{DSS}$	$V_{DS}=-20\text{ V}, V_{GS}=0\text{ V}, T_j=25\text{ °C}$	-	-	1	$\mu\text{A}$
		$V_{DS}=-20\text{ V}, V_{GS}=0\text{ V}, T_j=150\text{ °C}$	-	-	100	
Gate-source leakage current	$I_{GSS}$	$V_{GS}=-12\text{ V}, V_{DS}=0\text{ V}$	-	-	-100	nA
Drain-source on-state resistance	$R_{DS(on)}$	$V_{GS}=-2.5\text{ V}, I_D=-1.1\text{ A}$	-	166	280	$\text{m}\Omega$
		$V_{GS}=-4.5\text{ V}, I_D=-1.5\text{ A}$	-	105	150	
Transconductance	$g_{fs}$	$ V_{DS} >2 I_D R_{DS(on)max}, I_D=-1.18\text{ A}$	-	4.5	-	S

<sup>2)</sup> Performed on 40mm<sup>2</sup> FR4 PCB. The traces are 1mm wide, 70 $\mu\text{m}$  thick and 20mm long; they are present on both sides of the PCB.

Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	

**Dynamic characteristics**

Input capacitance	$C_{iss}$	$V_{GS}=0\text{ V},$ $V_{DS}=-15\text{ V}, f=1\text{ MHz}$	-	260	346	pF
Output capacitance	$C_{oss}$		-	102	135	
Reverse transfer capacitance	$C_{rss}$		-	85	128	
Turn-on delay time	$t_{d(on)}$	$V_{DD}=-10\text{ V},$ $V_{GS}=-4.5\text{ V},$ $I_D=-1.5\text{ A}, R_G=6\ \Omega$	-	6.7	-	ns
Rise time	$t_r$		-	9.7	-	
Turn-off delay time	$t_{d(off)}$		-	14.5	-	
Fall time	$t_f$		-	14.0	-	

**Gate Charge Characteristics**

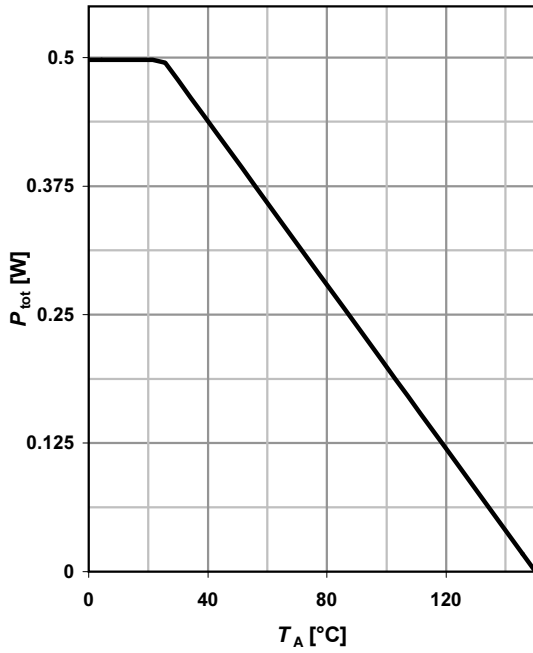
Gate to source charge	$Q_{gs}$	$V_{DD}=-16\text{ V},$ $I_D=-1.5\text{ A},$ $V_{GS}=0\text{ to }-4.5\text{ V}$	-	-0.49	-	nC
Gate to drain charge	$Q_{gd}$		-	-1.9	-	
Gate charge total	$Q_g$		-	-3.55	-	
Gate plateau voltage	$V_{plateau}$		-	-1.9	-	V

**Reverse Diode**

Diode continuous forward current	$I_S$	$T_A=25\text{ }^\circ\text{C}$	-	-	-0.5	A
Diode pulse current	$I_{S,pulse}$		-	-	-6	
Diode forward voltage	$V_{SD}$	$V_{GS}=0\text{ V}, I_F=-1.5\text{ A},$ $T_j=25\text{ }^\circ\text{C}$	-	-0.8	-1.1	V
Reverse recovery time	$t_{rr}$	$V_R=10\text{ V}, I_F=-1.5\text{ A},$ $di_F/dt=100\text{ A}/\mu\text{s}$	-	21.0	-	ns
Reverse recovery charge	$Q_{rr}$		-	-3.7	-	nC

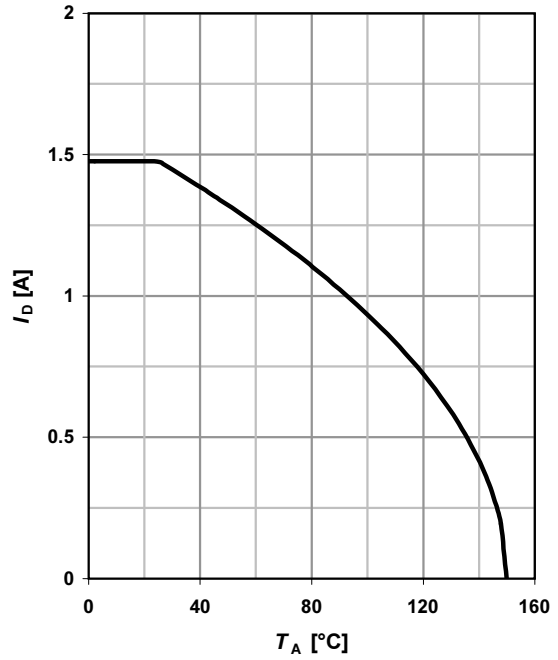
**1 Power dissipation**

$P_{tot}=f(T_A)$



**2 Drain current**

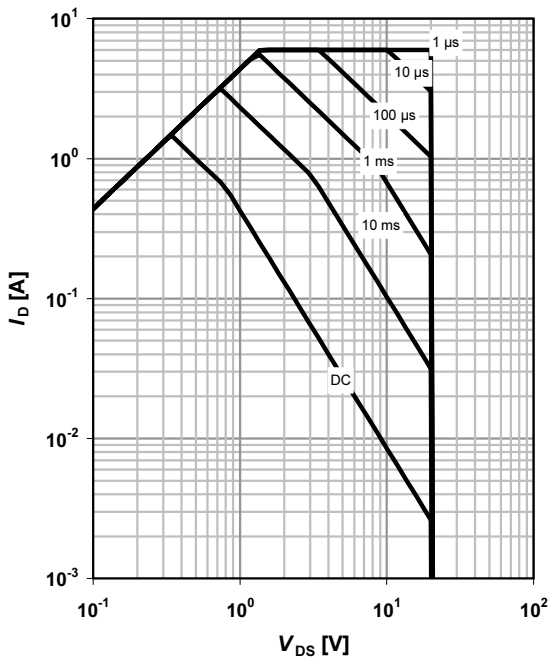
$I_D=f(T_A); V_{GS}\leq 4.5\text{ V}$



**3 Safe operating area**

$I_D=f(V_{DS}); T_A=25\text{ °C}; D=0$

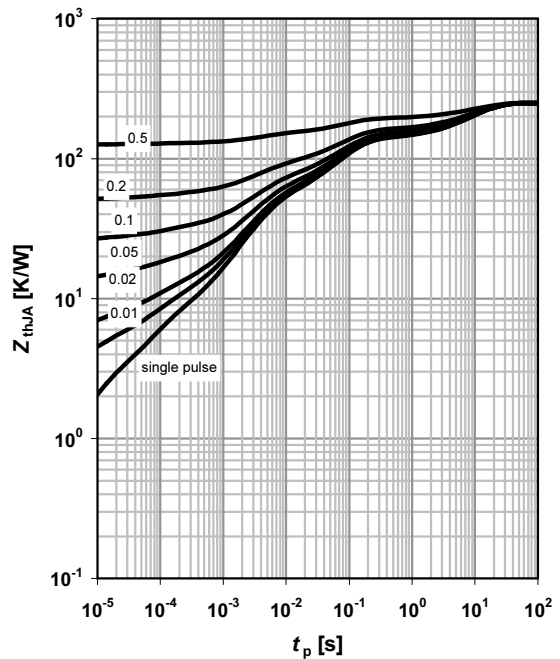
parameter:  $t_p$



**4 Max. transient thermal impedance**

$Z_{thJA}=f(t_p)$

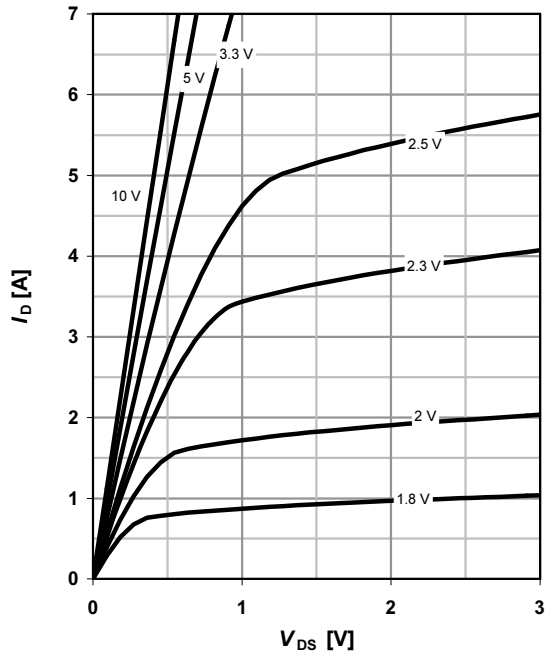
parameter:  $D=t_p/T$



**5 Typ. output characteristics**

$I_D = f(V_{DS}); T_J = 25\text{ }^\circ\text{C}$

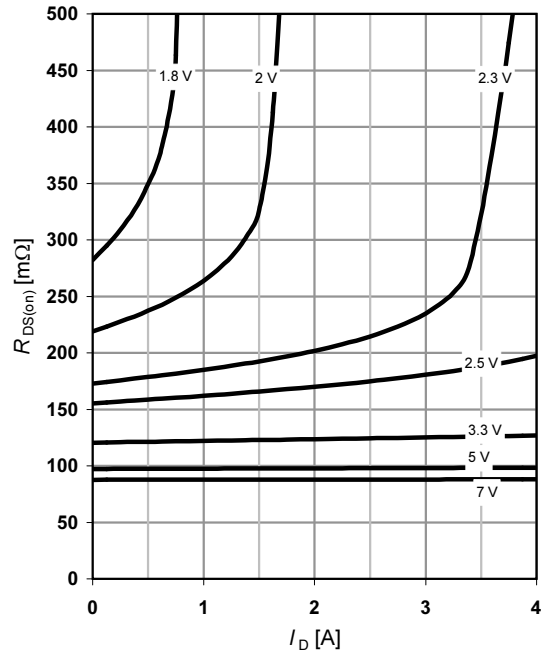
parameter:  $V_{GS}$



**6 Typ. drain-source on resistance**

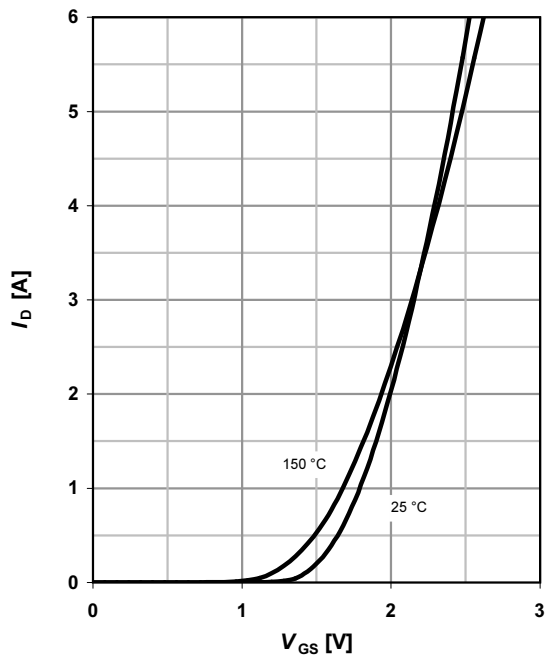
$R_{DS(on)} = f(I_D); T_J = 25\text{ }^\circ\text{C}$

parameter:  $V_{GS}$



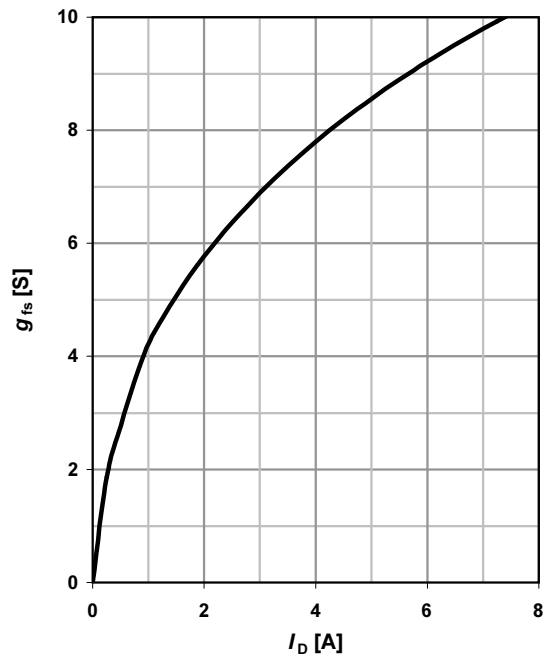
**7 Typ. transfer characteristics**

$I_D = f(V_{GS}); |V_{DS}| > 2|I_D|R_{DS(on)max}$



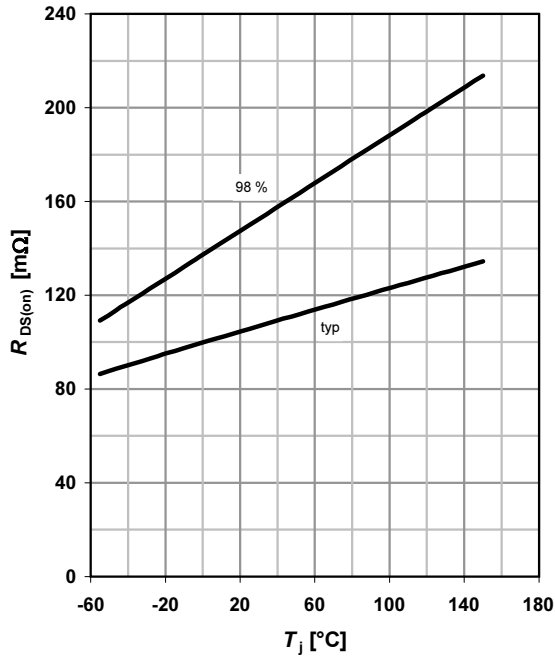
**8 Typ. forward transconductance**

$g_{fs} = f(I_D); T_J = 25\text{ }^\circ\text{C}$



**9 Drain-source on-state resistance**

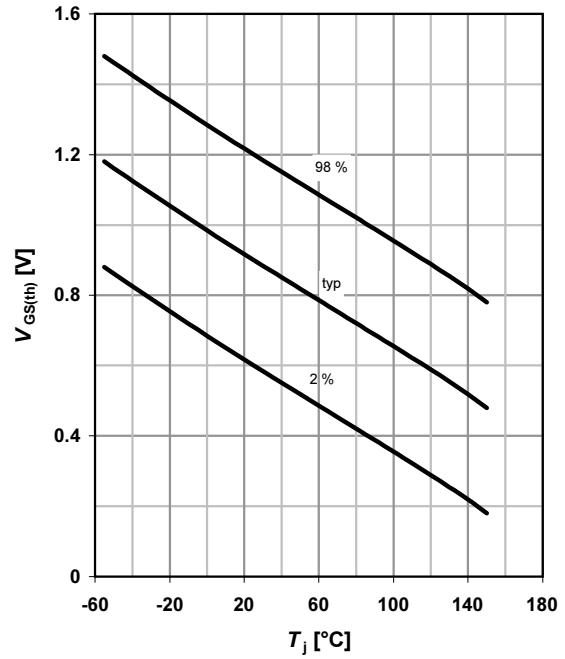
$R_{DS(on)} = f(T_j); I_D = -1.5 \text{ A}; V_{GS} = -4.5 \text{ V}$



**10 Typ. gate threshold voltage**

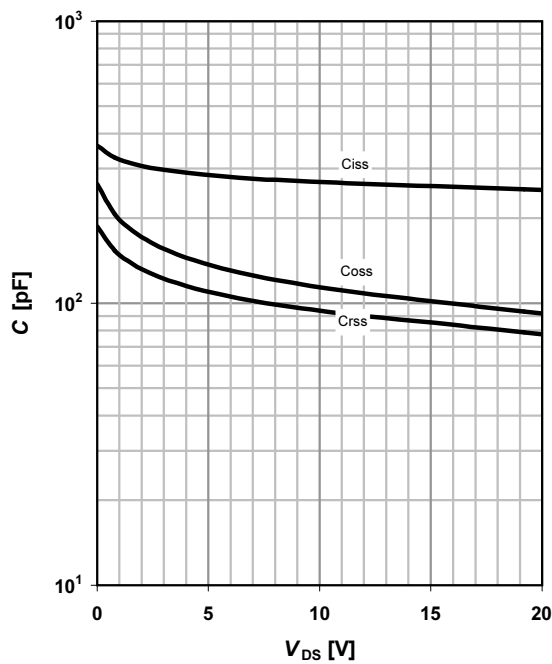
$V_{GS(th)} = f(T_j); V_{DS} = V_{GS}; I_D = -11 \mu\text{A}$

parameter:  $I_D$



**11 Typ. capacitances**

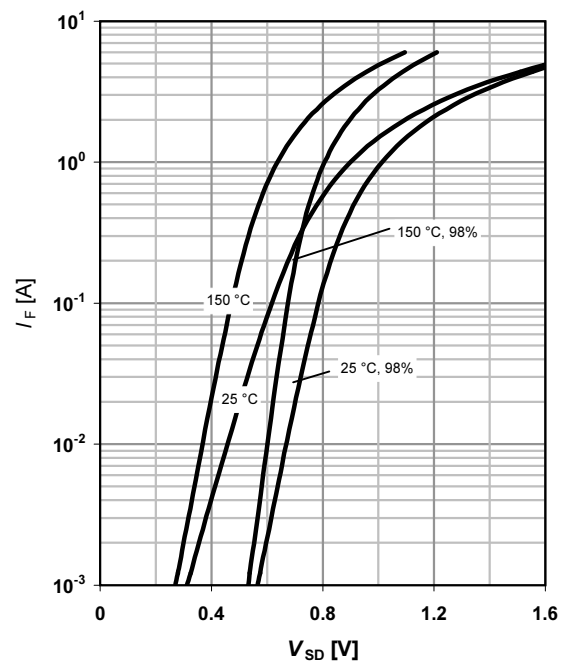
$C = f(V_{DS}); V_{GS} = 0 \text{ V}; f = 1 \text{ MHz}; T_j = 25^\circ\text{C}$



**12 Forward characteristics of reverse diode**

$I_F = f(V_{SD})$

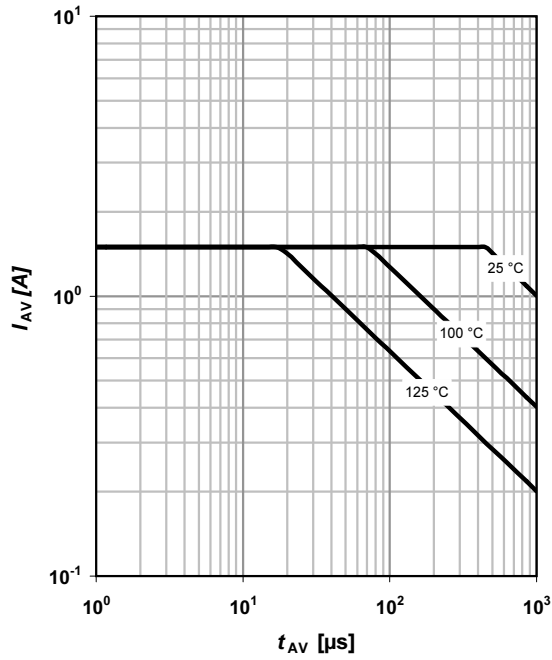
parameter:  $T_j$



**13 Avalanche characteristics**

$I_{AS}=f(t_{AV}); R_{GS}=25\Omega$

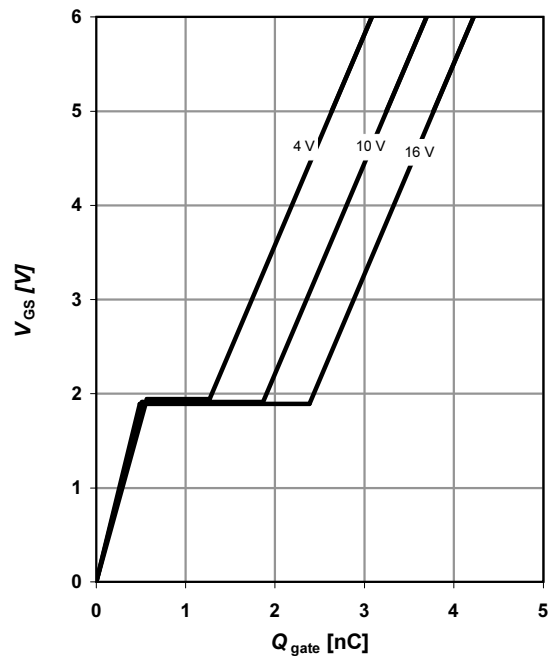
parameter:  $T_{j(start)}$



**14. Typ. Gate charge**

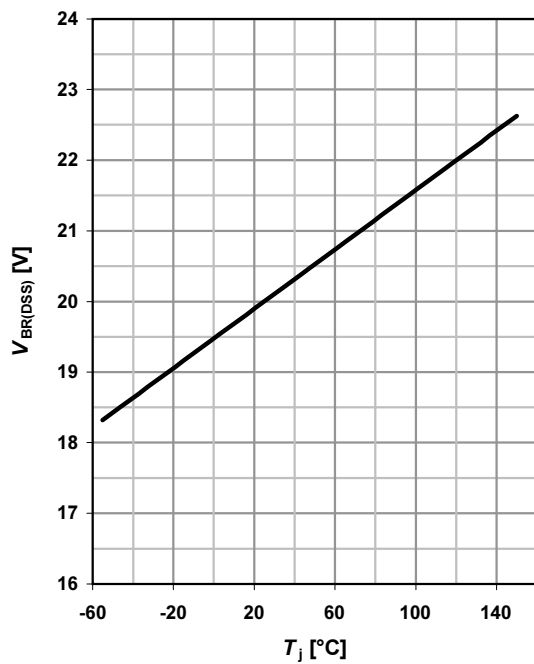
$V_{GS}=f(Q_{gate}); I_D=-1.5A$  pulsed

parameter:  $V_{DD}$

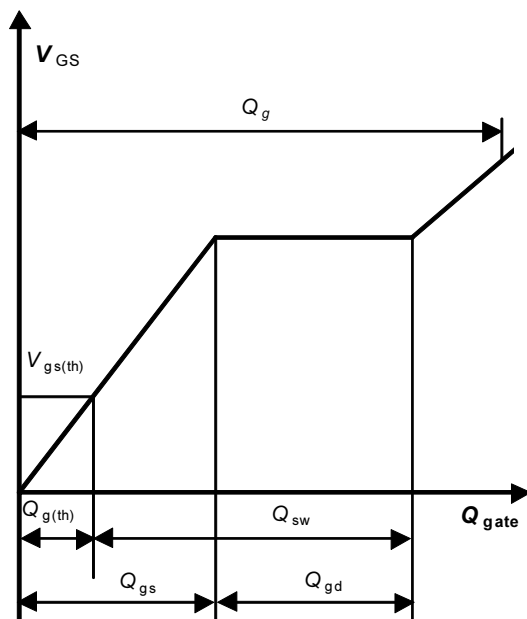


**15 Drain-source breakdown voltage**

$V_{BR(DSS)}=f(T_j); I_D=250\mu A$

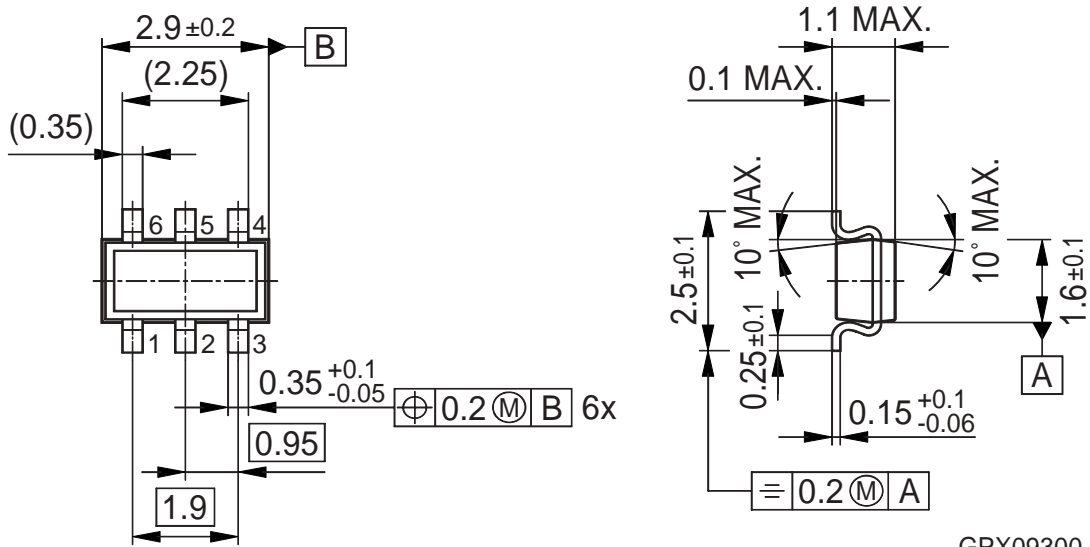


**16 Gate charge waveforms**

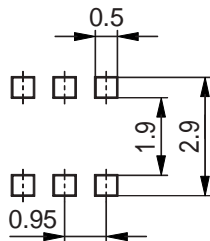


Package Outline:

TSOP6



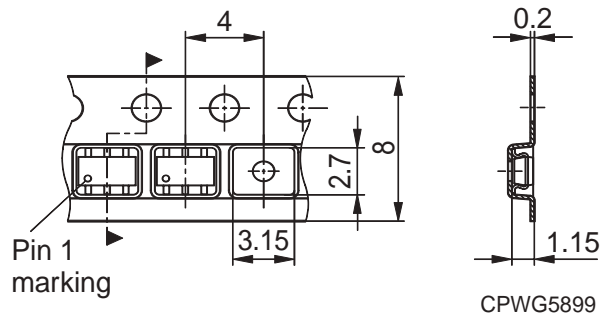
Footprint:



Remark: Wave soldering possible dep. on customers process conditions

HLG09283

Packaging:



Dimensions in mm



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